

### P-Channe12-V (D-S) MOSFET

#### **CHARACTERISTICS**

- P-Channel Vertical DMOS
- Macro Model (Subcircuit Model)
- Level 3 MOS

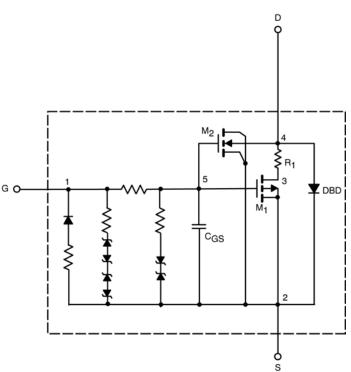
- Apply for both Linear and Switching Application
- Accurate over the -55 to 125°C Temperature Range
- Model the Gate Charge, Transient, and Diode Reverse Recovery Characteristics

#### DESCRIPTION

The attached spice model describes the typical electrical characteristics of the p-channel vertical DMOS. The subcircuit model is extracted and optimized over the -55 to  $125^{\circ}$ C temperature ranges under the pulsed 0-V to 5-V gate drive. The saturated output impedance is best fit at the gate bias near the threshold voltage.

#### SUBCIRCUIT MODEL SCHEMATIC

A novel gate-to-drain feedback capacitance network is used to model the gate charge characteristics while avoiding convergence difficulties of the switched  $C_{gd}$  model. All model parameter values are optimized to provide a best fit to the measured electrical data and are not intended as an exact physical interpretation of the device.



This document is intended as a SPICE modeling guideline and does not constitute a commercial product data sheet. Designers should refer to the appropriate data sheet of the same number for guaranteed specification limits.



| SPECIFICATIONS (T <sub>J</sub> = 25°C UNLESS OTHERWISE NOTED) |                     |  |                   |                  |      |
|---|---------------------|--|-------------------|------------------|------|
| Parameter   | Symbol              | Test Condition   | Simulated<br>Data | Measured<br>Data | Unit |
| Static  | -                   |  | -                 |                  |      |
| Gate Threshold Voltage  | V <sub>GS(th)</sub> | $V_{DS}$ = $V_{GS}$ , $I_D$ = -250 $\mu$ A   | 0.70              |                  | V    |
| On-State Drain Current <sup>a</sup>                           | I <sub>D(on)</sub>  | $V_{DS}$ = -5 V, $V_{GS}$ = -4.5 V   | 50                |                  | А    |
| Drain-Source On-State Resistance <sup>a</sup>                 | ۲ <sub>DS(on)</sub> | $V_{GS}$ = -4.5 V, I <sub>D</sub> = -3.3 A   | 0.060             | 0.070            | Ω    |
|   |                     | $V_{GS}$ = -2.5 V, I <sub>D</sub> = -2.9 A   | 0.096             | 0.095            |      |
|   |                     | $V_{GS}$ = -1.8 V, I <sub>D</sub> = -1.0 A   | 0.141             | 0.133            |      |
| Forward Transconductance <sup>a</sup>                         | 9 <sub>fs</sub>     | $V_{DS}$ = -10 V, $I_{D}$ = -3.3 A   | 8.2               | 8                | S    |
| Diode Forward Voltage <sup>a</sup>                            | V <sub>SD</sub>     | $I_{\rm S}$ = -1.4 A, $V_{\rm GS}$ = 0 V   | -0.80             | -0.80            | V    |
| Dynamic <sup>b</sup>  | -                   |  | •                 |                  |      |
| Total Gate Charge <sup>b</sup>                                | Qg                  | $V_{DS}$ = -6 V, $V_{GS}$ = -4.5 V, $I_{D}$ = -3.3 A   | 5.6               | 5.8              | nC   |
| Gate-Source Charge <sup>b</sup>                               | Q <sub>gs</sub>     |  | 1.3               | 1.3              |      |
| Gate-Drain Charge <sup>b</sup>                                | Q <sub>gd</sub>     |  | 1.5               | 1.5              |      |
| Turn-On Delay Time <sup>b</sup>                               | t <sub>d(on)</sub>  | $V_{\text{DD}}$ = -6 V, R <sub>L</sub> = 6 $\Omega$<br>I <sub>D</sub> $\cong$ -1 A, V <sub>GEN</sub> = -4.5 V, R <sub>G</sub> = 6 $\Omega$ | 1.3               | 0.60             | ns   |
| Rise Time <sup>b</sup>  | tr                  |  | 3.7               | 1.4              |      |
| Turn-Off Delay Time <sup>b</sup>                              | t <sub>d(off)</sub> |  | 7.2               | 4.9              |      |
| Fall Time <sup>b</sup>  | t <sub>f</sub>      |  | 15                | 4.9              |      |

Notes

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2%. b. Guaranteed by design, not subject to production testing.



# **SPICE Device Model Si1417EDH**

# Vishay Siliconix

-55°C

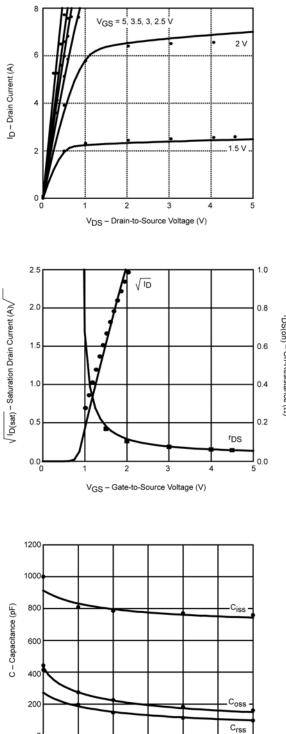
25°C

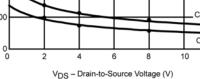
2.5

2.0

T<sub>C</sub> = 125°C

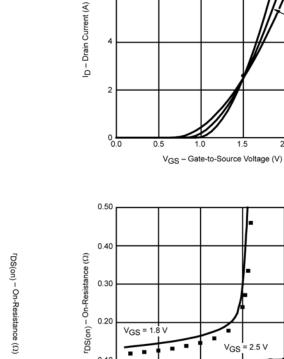
COMPARISON OF MODEL WITH MEASURED DATA (TJ=25°C UNLESS OTHERWISE NOTED)

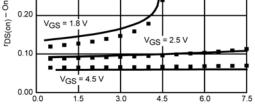




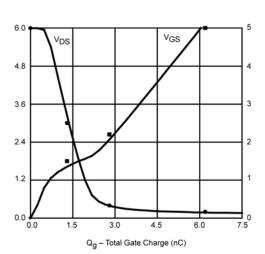
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Note: Dots and squares represent measured data





I<sub>D</sub> – Drain Current (A)



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